UNR3113, UNR311A, UNR311T

Silicon PNP epitaxial planar transistor

For digital circuits

■ Features

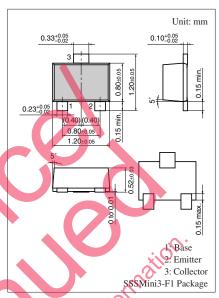
- Optimum for downsizing of the equipment and high-density mounting
- Contribute for low power consumption

■ Resistance by Part Number

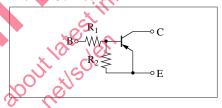
	Marking symbol	(R_1)	(R_2)	
• UNR3113	6C	$47~\mathrm{k}\Omega$	$47~\mathrm{k}\Omega$	
• UNR311A	6X	$100~\text{k}\Omega$	$100 \text{ k}\Omega$	
• UNR311T	EY	$22 \text{ k}\Omega$	$47~\mathrm{k}\Omega$	

■ Absolute Maximum Ratings $T_a = 25$ C

Parameter	Symbol	Rating	Unit
Collector to base voltage	V_{CBO}	-50	V
Collector to emitter voltage	V_{CEO}	- 50	V
Collector current	I_{C}	-100	mA
Total power dissipation	P_{T}	100	mW
Junction temperature	T_{j}	125	°C
Storage temperature	T_{stg}	-55 to +125	°C



Internal Connection



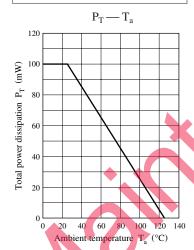
■ Electrical Characteristics $T_a = 25^{\circ}C \pm 3^{\circ}C$

Paran	neter	Symbol	Conditions	Min	Тур	Max	Unit
Collector to base	voltage	V_{CBO}	$I_{\rm C} = -10 \mu A I_{\rm E} = 0$	-50			V
Collector to emitte	er voltage	V _{CEO}	$I_{\rm C} = -2 \text{mA}, I_{\rm B} = 0$	-50			V
Collector cutoff c	urrent	I _{CBO}	$V_{CB} = -50 \text{ V}, I_E = 0$			- 0.1	μΑ
		I _{CEO}	$V_{CE} = -50 \text{ V}, I_B = 0$			- 0.5	
Emitter cutoff	UNR3113, 311A	O I _{EBO}	$V_{EB} = -6 \text{ V}, I_C = 0$			- 0.1	mA
current	UNR311T					- 0.2	
Forward current	UNR3113, 311A	h _{FE}	$V_{CE} = -10 \text{ V}, I_{C} = -5 \text{ mA}$	80			
transfer ratio	UNR311T			80		400	
Collector to emitter	saturation voltage	V _{CE(sat)}	$I_C = -10 \text{ mA}, I_B = -0.3 \text{ mA}$			- 0.25	V
High-level output	voltage	V _{OH}	$V_{CC} = -5 \text{ V}, V_B = -0.5 \text{ V}, R_L = 1 \text{ k}\Omega$	-4.9			V
Low-level output	voltage UNR3113	V _{OL}	$V_{CC} = -5 \text{ V}, V_B = -3.5 \text{ V}, R_L = 1 \text{ k}\Omega$			- 0.2	V
	UNR311A		$V_{CC} = -5 \text{ V}, V_B = -5.0 \text{ V}, R_L = 1 \text{ k}\Omega$				
	UNR311T		$V_{CC} = -5 \text{ V}, V_B = -2.5 \text{ V}, R_L = 1 \text{ k}\Omega$				

■ Electrical Characteristics (continued) $T_a = 25$ °C ± 3 °C

Para	meter	Symbol	Conditions	Min	Тур	Max	Unit
Input resistance	UNR3113	R ₁		-30%	47	+30%	kΩ
	UNR311A				100		
	UNR311T				22		
Resistance ratio	UNR3113	R ₁ / R ₂		0.8	1.0	1.2	
	UNR311A				1.0		
	UNR311T			0.37	0.47	0.57	
Gain bandwidth	product	f_T	$V_{CB} = -10 \text{ V}, I_E = 1 \text{ mA}, f = 200 \text{ MHz}$		80		MHz

Common characteristics chart



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